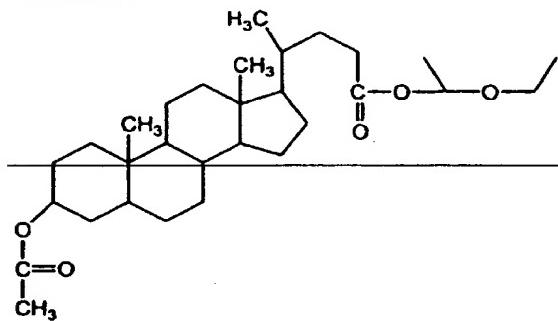


In the Claims:

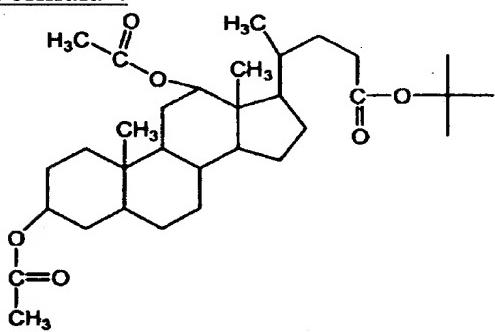
Please amend claims 1, 3 and 6, as follows:

Claim 1 (currently amended) An additive of following Formulas 3-7 4 or 6 for a photoresist composition for a resist flow process:

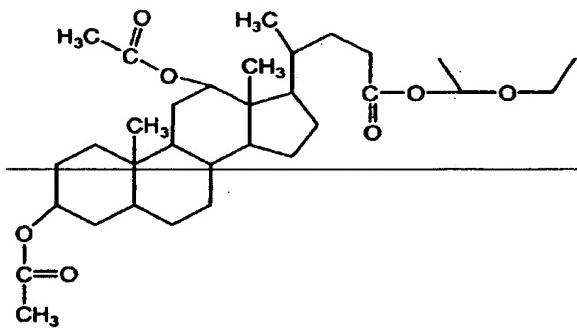
Formula 3



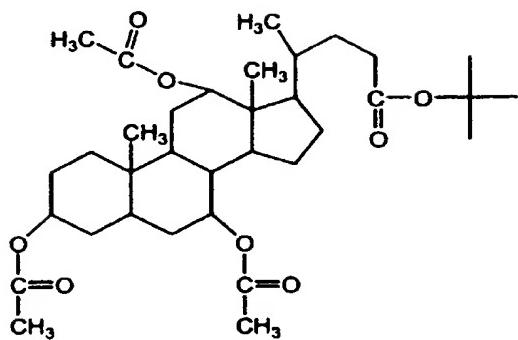
Formula 4



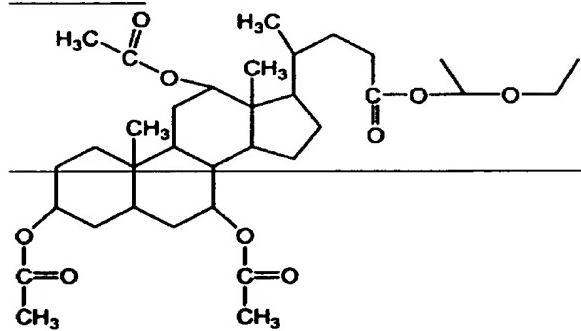
Formula 5



Formula 6



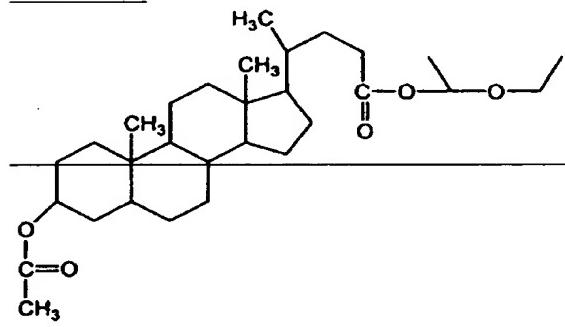
Formula 7



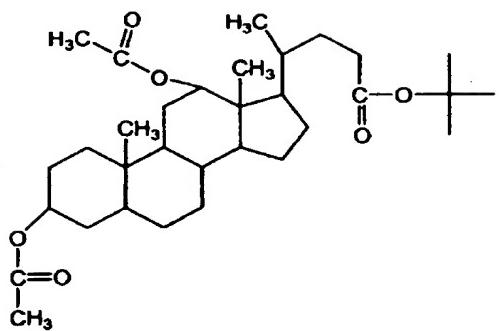
Claim 2 (previously canceled)

Claim 3 (currently amended) A photoresist composition comprising:
a photoresist polymer, a photoacid generator, an additive of following
Formulas 3-7 4 or 6, and an organic solvent,

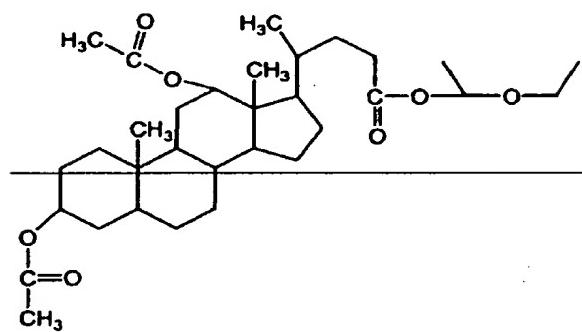
Formula 3



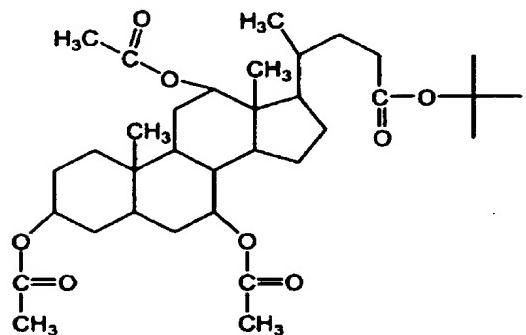
Formula 4



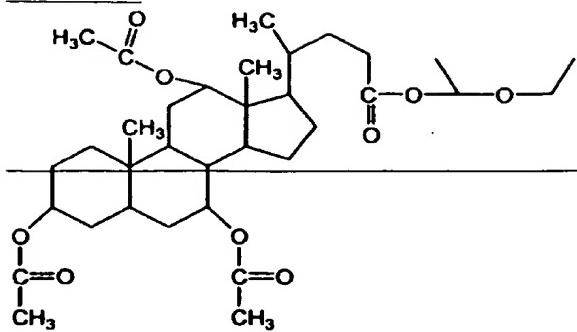
Formula 5



Formula 6



Formula 7

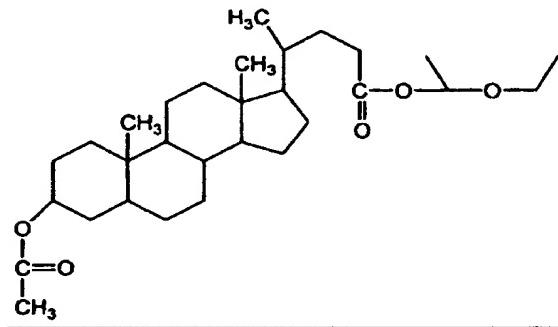


Claims 4-5 (previously canceled)

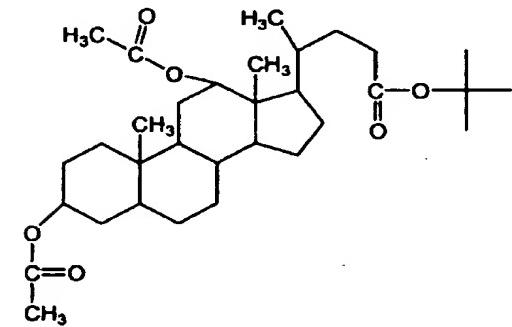
Claim 6 (currently amended) The photoresist composition of claim 3 A photoresist composition comprising:

a photoresist polymer, a photoacid generator, an additive of following Formulas 3-7 and an organic solvent,

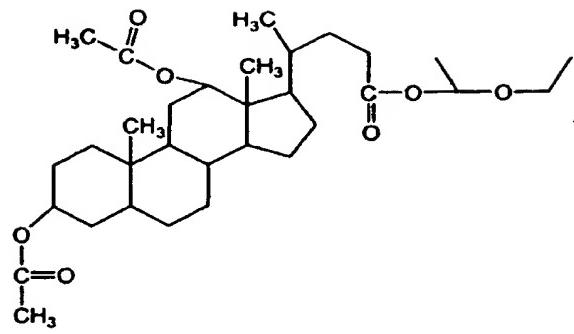
Formula 3



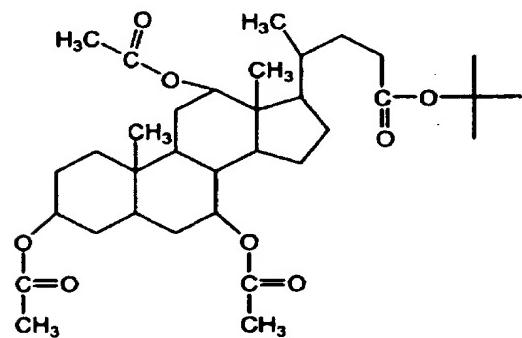
Formula 4



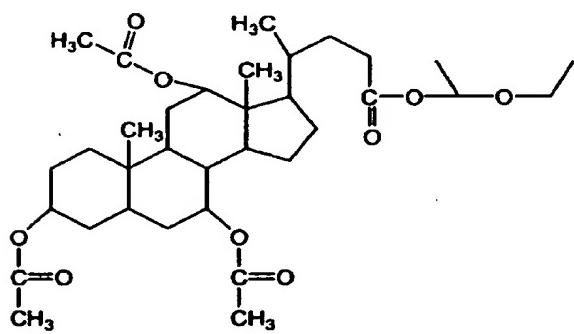
Formula 5



Formula 6



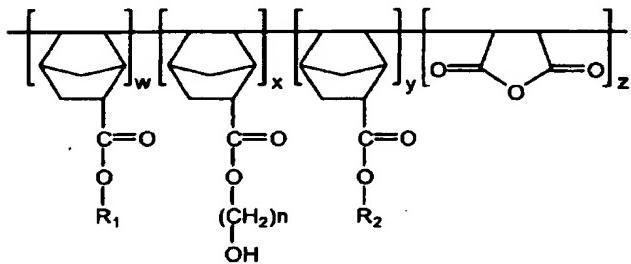
Formula 7



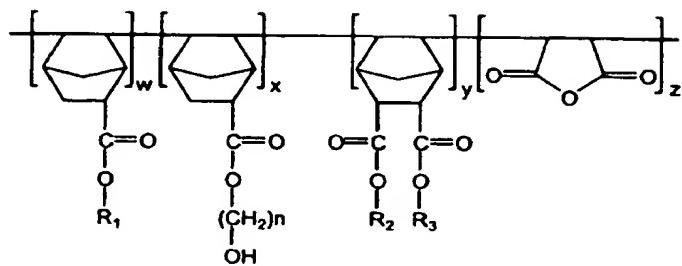
; and

wherein the photoresist polymer is a compound of following Formulas 8 or 9:

Formula 8



Formula 9



R_2 is hydrogen;

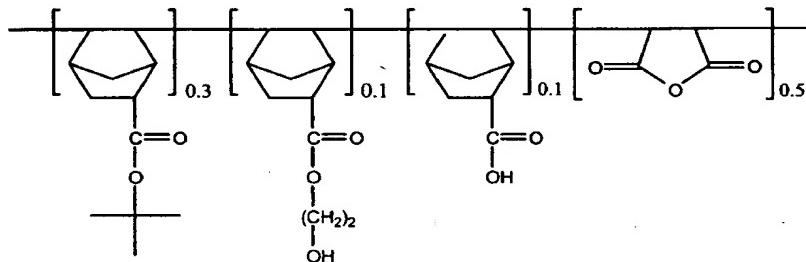
R_3 is hydrogen, selected from the group consisting of C_1-C_{10} alkyl, C_1-C_{10} alkoxyalkyl, and C_1-C_{10} alkyl containing at least one hydroxyl group ($-OH$);

n is an integer from 1 to 5; and

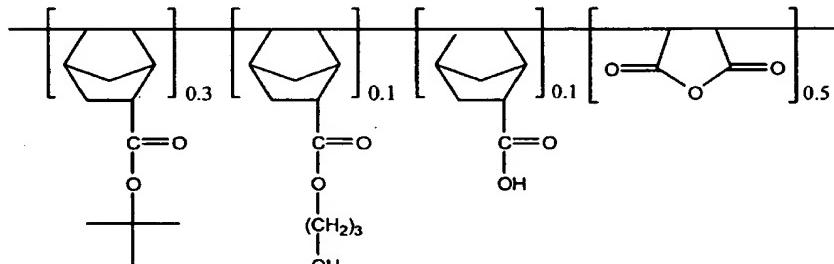
w , x , y and z individually denote the mole ratio of each monomer, preferably with proviso that $w + x + y = 50\text{mol\%}$, and z is 50mol\% .

Claim 7 (previously amended) The photoresist composition of claim 6 wherein the photoresist polymer is selected from the group consisting of compounds of following Formulas 10 to 13:

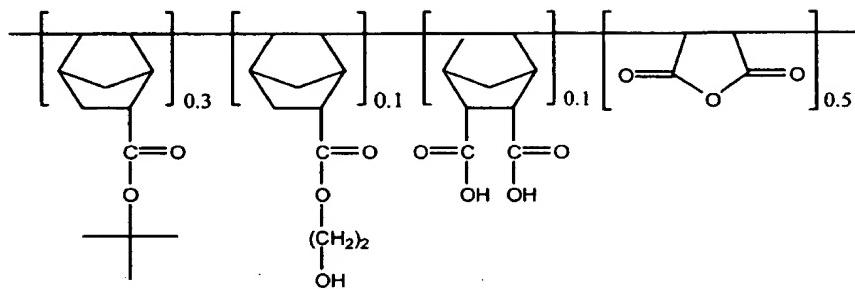
Formula 10



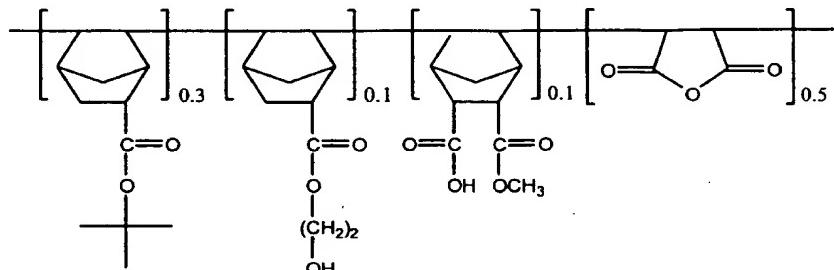
Formula 11



Formula 12



Formula 13



Claim 8 (original) The photoresist composition of claim 3 wherein the additive is present in an amount ranging from about 1 to about 70% by weight of the photoresist polymer.

Claim 9 (original) The photoresist composition of claim 3 wherein said photoacid generator is selected from the group consisting of diphenyl iodide hexafluorophosphate, diphenyl iodide hexafluoroarsenate, diphenyl iodide hexafluoroantimonate, diphenyl p-methoxyphenyl triflate, diphenyl p-toluenyl triflate, diphenyl p-isobutylphenyl triflate, diphenyl p-tert-butylphenyl triflate, triphenylsulfonium hexafluorophosphate, triphenylsulfonium hexafluoroarsenate, triphenylsulfonium hexafluoroantimonate, triphenylsulfonium triflate, dibutylnaphthylsulfonium triflate, and mixtures thereof .

Claim 10 (original) The photoresist composition of claim 3 wherein the photoacid generator is present in an amount ranging from about 0.01 to about 10% by weight of the photoresist polymer.

Claim 11 (original) The photoresist composition of claim 3 wherein the organic solvent is selected from the group consisting of propyleneglycol methyl ether acetate, ethyl lactate, methyl 3-methoxypropionate, ethyl 3-ethoxypropionate and cyclohexanone.

Claim 12 (original) The photoresist composition of claim 3 wherein the organic solvent is present in a range of from about 100 % to about 1000% by weight of the photoresist polymer.

Claims 13-20 (previously canceled)